

Notice of References Cited	Application/Control No. 09/834,410		Applicant(s)/Patent Under Reexamination SAWADA ET AL.	
	Examiner Micah-Paul Young		Art Unit 1618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,922,352	07-1999	Chen et al.	424/465
	B	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	
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